

Notice of References Cited	Application/Control No. 10/054,514	Applicant(s)/Patent Under. Reexamination STELTER ET AL.	
	Examiner Mark A. Chapman	Art Unit 1756	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0022190	02-2002	Iizuka et al.	430/110.4
	B	US-5,866,289	02-1999	Asanae et al.	430/111.41
	C	US-3,895,125	07-1975	Tsuchiya et al.	430/122
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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